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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/034,057	LIU ET AL.	
Examiner	Art Unit	
Bob A. Phunkulh	2616	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
370/437, 468, 477 (text search)	11/16/2005	ВАР
375/240.01, 240.02 (Text search)	11/16/2005	ВАР
EAST (text search-Updated)	5/15/2006	ВАР
EAST (text search)	10/31/2006	ВАР